

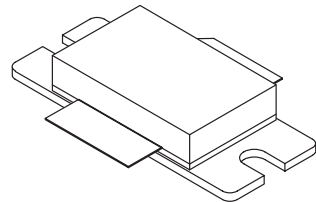
The RF Sub-Micron MOSFET Line  
**RF Power Field Effect Transistors**  
N-Channel Enhancement-Mode Lateral MOSFETs

Designed for PCN and PCS base station applications with frequencies from 1.9 to 2.0 GHz. Suitable for TDMA, CDMA and multicarrier amplifier applications.

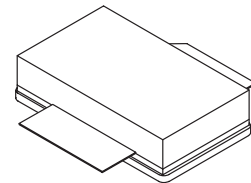
- Typical 2-Carrier N-CDMA Performance for  $V_{DD} = 26$  Volts,  $I_{DQ} = 1300$  mA,  $f_1 = 1958.75$  MHz,  $f_2 = 1961.25$  MHz IS-95 CDMA (Pilot, Sync, Paging, Traffic Codes 8 Through 13) 1.2288 MHz Channel Bandwidth Carrier. Adjacent Channels Measured over a 30 kHz Bandwidth at  $f_1 -885$  kHz and  $f_2 +885$  kHz. Distortion Products Measured over 1.2288 MHz Bandwidth at  $f_1 -2.5$  MHz and  $f_2 +2.5$  MHz. Peak/Avg. = 9.8 dB @ 0.01% Probability on CCDF.  
Output Power — 24 Watts Avg.  
Power Gain — 13.6 dB  
Efficiency — 22%  
ACPR — -51 dB  
IM3 — -37.0 dBc
- Internally Matched, Controlled Q, for Ease of Use
- High Gain, High Efficiency and High Linearity
- Integrated ESD Protection
- Designed for Maximum Gain and Insertion Phase Flatness
- Capable of Handling 5:1 VSWR, @ 26 Vdc, 1990 MHz, 125 Watts (CW) Output Power
- Excellent Thermal Stability
- Characterized with Series Equivalent Large-Signal Impedance Parameters
- Available in Tape and Reel. R3 Suffix = 250 Units per 56 mm, 13 inch Reel.

**MRF19125**  
**MRF19125S**  
**MRF19125SR3**

**1990 MHz, 125 W, 26 V**  
**LATERAL N-CHANNEL**  
**RF POWER MOSFETs**



**CASE 465B-03, STYLE 1**  
**(NI-880)**  
**(MRF19125)**



**CASE 465C-02, STYLE 1**  
**(NI-880S)**  
**(MRF19125S)**

**MAXIMUM RATINGS**

Rating	Symbol	Value	Unit
Drain-Source Voltage	$V_{DSS}$	65	Vdc
Gate-Source Voltage	$V_{GS}$	+15, -0.5	Vdc
Total Device Dissipation @ $T_C = 25^\circ\text{C}$ Derate above $25^\circ\text{C}$	$P_D$	330 1.89	Watts W/ $^\circ\text{C}$
Storage Temperature Range	$T_{stg}$	-65 to +200	$^\circ\text{C}$
Operating Junction Temperature	$T_J$	200	$^\circ\text{C}$

**ESD PROTECTION CHARACTERISTICS**

Test Conditions	Class
Human Body Model	2 (Minimum)
Machine Model	M3 (Minimum)

**THERMAL CHARACTERISTICS**

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Case	$R_{\theta JC}$	0.53	$^\circ\text{C/W}$

NOTE – **CAUTION** – MOS devices are susceptible to damage from electrostatic charge. Reasonable precautions in handling and packaging MOS devices should be observed.

**ELECTRICAL CHARACTERISTICS** ( $T_C = 25^\circ\text{C}$  unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
<b>OFF CHARACTERISTICS</b>					
Drain–Source Breakdown Voltage ( $V_{GS} = 0\text{ Vdc}$ , $I_D = 100\ \mu\text{Adc}$ )	$V_{(BR)DSS}$	65	—	—	Vdc
Gate–Source Leakage Current ( $V_{GS} = 5\text{ Vdc}$ , $V_{DS} = 0\text{ Vdc}$ )	$I_{GSS}$	—	—	1	$\mu\text{Adc}$
Zero Gate Voltage Drain Leakage Current ( $V_{DS} = 26\text{ Vdc}$ , $V_{GS} = 0\text{ Vdc}$ )	$I_{DSS}$	—	—	10	$\mu\text{Adc}$

**ON CHARACTERISTICS**

Forward Transconductance ( $V_{DS} = 10\text{ Vdc}$ , $I_D = 3\text{ Adc}$ )	$g_{fs}$	—	9	—	S
Gate Threshold Voltage ( $V_{DS} = 10\text{ Vdc}$ , $I_D = 300\ \mu\text{Adc}$ )	$V_{GS(th)}$	2	—	4	Vdc
Gate Quiescent Voltage ( $V_{DS} = 26\text{ Vdc}$ , $I_D = 1300\text{ mAdc}$ )	$V_{GS(Q)}$	2.5	3.9	4.5	Vdc
Drain–Source On–Voltage ( $V_{GS} = 10\text{ Vdc}$ , $I_D = 3\text{ Adc}$ )	$V_{DS(on)}$	—	0.185	0.21	Vdc

**DYNAMIC CHARACTERISTICS**

Reverse Transfer Capacitance (1) ( $V_{DS} = 26\text{ Vdc}$ , $V_{GS} = 0$ , $f = 1\text{ MHz}$ )	$C_{rss}$	—	5.4	—	pF
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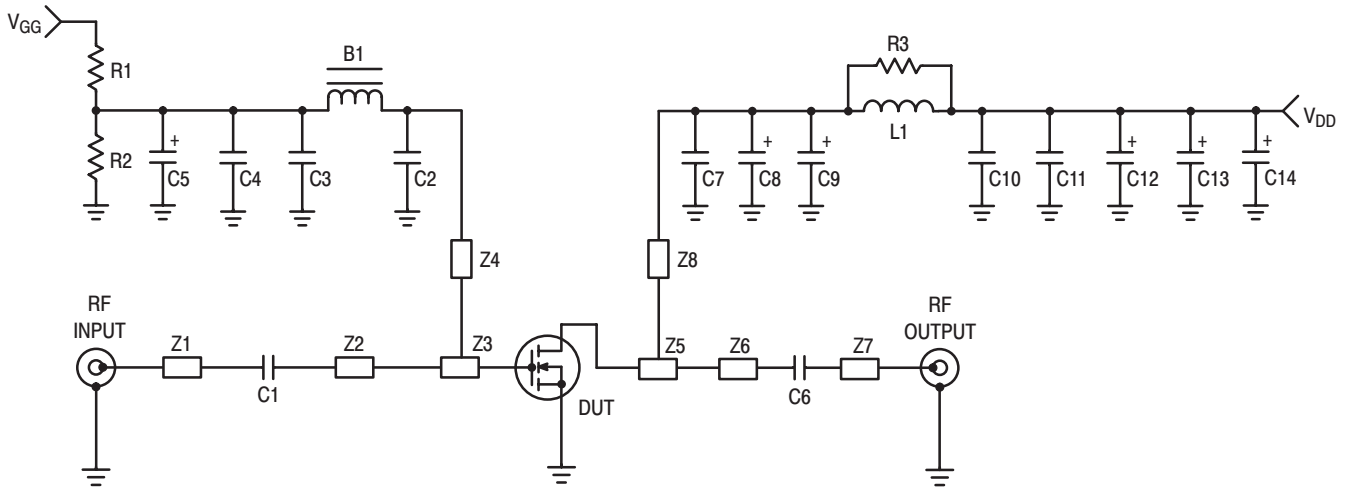
**FUNCTIONAL TESTS** (In Motorola Test Fixture) 2–Carrier N–CDMA, 1.2288 MHz Channel Bandwidth Carriers. Peak/Avg = 9.8 dB @ 0.01% Probability on CCDF.

Common–Source Amplifier Power Gain ( $V_{DD} = 26\text{ Vdc}$ , $P_{out} = 24\text{ W Avg}$ , $I_{DQ} = 1300\text{ mA}$ , $f_1 = 1930\text{ MHz}$ , $f_2 = 1932.5\text{ MHz}$ and $f_1 = 1987.5\text{ MHz}$ , $f_2 = 1990\text{ MHz}$ )	$G_{ps}$	12	13.5	—	dB
Drain Efficiency ( $V_{DD} = 26\text{ Vdc}$ , $P_{out} = 24\text{ W Avg}$ , $I_{DQ} = 1300\text{ mA}$ , $f_1 = 1930\text{ MHz}$ , $f_2 = 1932.5\text{ MHz}$ and $f_1 = 1987.5\text{ MHz}$ , $f_2 = 1990\text{ MHz}$ )	$\eta$	19	22	—	%
Intermodulation Distortion ( $V_{DD} = 26\text{ Vdc}$ , $P_{out} = 24\text{ W Avg}$ , $I_{DQ} = 1300\text{ mA}$ , $f_1 = 1930\text{ MHz}$ , $f_2 = 1932.5\text{ MHz}$ and $f_1 = 1987.5\text{ MHz}$ , $f_2 = 1990\text{ MHz}$ ; IM3 measured over 1.2288 MHz Bandwidth at $f_1 - 2.5\text{ MHz}$ and $f_2 + 2.5\text{ MHz}$ )	IMD	—	–37	–35	dBc
Adjacent Channel Power Ratio ( $V_{DD} = 26\text{ Vdc}$ , $P_{out} = 24\text{ W Avg}$ , $I_{DQ} = 1300\text{ mA}$ , $f_1 = 1930\text{ MHz}$ , $f_2 = 1932.5\text{ MHz}$ and $f_1 = 1987.5\text{ MHz}$ , $f_2 = 1990\text{ MHz}$ ; ACPR measured over 30 kHz Bandwidth at $f_1 - 885\text{ MHz}$ and $f_2 + 885\text{ MHz}$ )	ACPR	—	–51	–47	dBc
Input Return Loss ( $V_{DD} = 26\text{ Vdc}$ , $P_{out} = 24\text{ W Avg}$ , $I_{DQ} = 1300\text{ mA}$ , $f_1 = 1930\text{ MHz}$ , $f_2 = 1932.5\text{ MHz}$ and $f_1 = 1987.5\text{ MHz}$ , $f_2 = 1990\text{ MHz}$ )	IRL	—	–13	–9	dB
Output Mismatch Stress ( $V_{DD} = 26\text{ Vdc}$ , $P_{out} = 125\text{ W CW}$ , $I_{DQ} = 1300\text{ mA}$ , $f = 1930\text{ MHz}$ , $V_{SWR} = 5:1$ , All Phase Angles at Frequency of Test)	$\Psi$	No Degradation In Output Power Before and After Test			

(1) Part is internally matched both on input and output.

**ELECTRICAL CHARACTERISTICS — continued** ( $T_C = 25^\circ\text{C}$  unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
<b>FUNCTIONAL TESTS</b> (In Motorola Test Fixture)					
Two-Tone Common-Source Amplifier Power Gain ( $V_{DD} = 26\text{ Vdc}$ , $P_{out} = 125\text{ W PEP}$ , $I_{DQ} = 1300\text{ mA}$ , $f_1 = 1930\text{ MHz}$ , $f_2 = 1990\text{ MHz}$ , Tone Spacing = 100 kHz)	$G_{ps}$	—	13.5	—	dB
Two-Tone Drain Efficiency ( $V_{DD} = 26\text{ Vdc}$ , $P_{out} = 125\text{ W PEP}$ , $I_{DQ} = 1300\text{ mA}$ , $f_1 = 1930\text{ MHz}$ , $f_2 = 1990\text{ MHz}$ , Tone Spacing = 100 kHz)	$\eta$	—	35	—	%
Third Order Intermodulation Distortion ( $V_{DD} = 26\text{ Vdc}$ , $P_{out} = 125\text{ W PEP}$ , $I_{DQ} = 1300\text{ mA}$ , $f_1 = 1930\text{ MHz}$ , $f_2 = 1990\text{ MHz}$ , Tone Spacing = 100 kHz)	IMD	—	-30	—	dBc
Input Return Loss ( $V_{DD} = 26\text{ Vdc}$ , $P_{out} = 125\text{ W PEP}$ , $I_{DQ} = 1300\text{ mA}$ , $f_1 = 1930\text{ MHz}$ , $f_2 = 1990\text{ MHz}$ , Tone Spacing = 100 kHz)	IRL	—	-13	—	dB
$P_{out}$ : 1 dB Compression Point ( $V_{DD} = 26\text{ Vdc}$ , $I_{DQ} = 1300\text{ mA}$ , $f = 1990\text{ MHz}$ )	P1dB	—	130	—	W



Z1, Z7      0.500" x 0.084" Microstrip  
 Z2          1.105" x 0.084" Microstrip  
 Z3          0.360" x 0.895" Microstrip  
 Z4          0.920" x 0.048" Microstrip  
 Z5          0.605" x 1.195" Microstrip  
 Z6          0.800" x 0.084" Microstrip  
 Z8          0.660" x 0.095" Microstrip

Board      0.030" Glass Teflon<sup>®</sup>,  
 Keene GX-0300-55-22,  $\epsilon_r = 2.55$   
 PCB        Etched Circuit Boards  
 MRF19125 Rev. 5, CMR

**Figure 1. MRF19125 Test Circuit Schematic**

**Table 1. MRF19125 Test Circuit Component Designations and Values**

Designators	Description
B1	Short Ferrite Bead, Fair Rite #2743019447
C1	51 pF Chip Capacitor, ATC #100B510JCA500X
C2, C7	5.1 pF Chip Capacitors, ATC #100B5R1JCA500X
C3, C10	1000 pF Chip Capacitors, ATC #100B102JCA500X
C4, C11	0.1 $\mu$ F Chip Capacitors, Kemet #CDR33BX104AKWS
C5	0.1 $\mu$ F Tantalum Chip Capacitor, Kemet #T491C105M050
C6	10 pF Chip Capacitor, ATC #100B100JCA500X
C8	10 $\mu$ F Tantalum Chip Capacitor, Kemet #T491X106K035AS4394
C9, C12, C13, C14	22 $\mu$ F Tantalum Chip Capacitors, Kemet #T491X226K035AS4394
L1	1 Turn, #20 AWG, 0.100" ID, Motorola
N1, N2	Type N Flange Mounts, Omni Spectra #3052-1648-10
R1	1.0 k $\Omega$ , 1/8 W Chip Resistor
R2	220 k $\Omega$ , 1/8 W Chip Resistor
R3	10 $\Omega$ , 1/8 W Chip Resistor

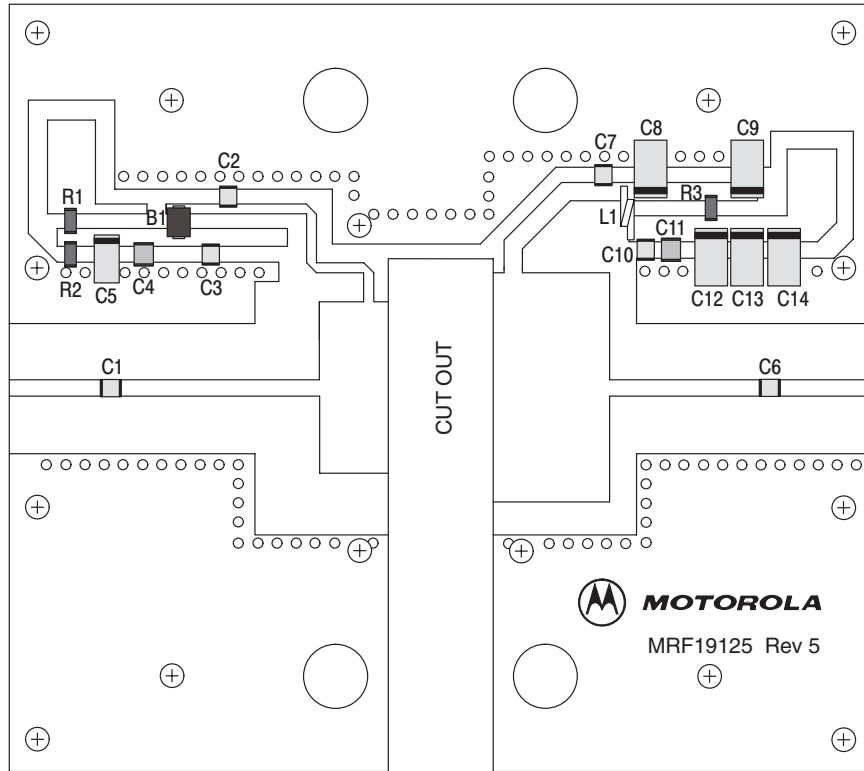
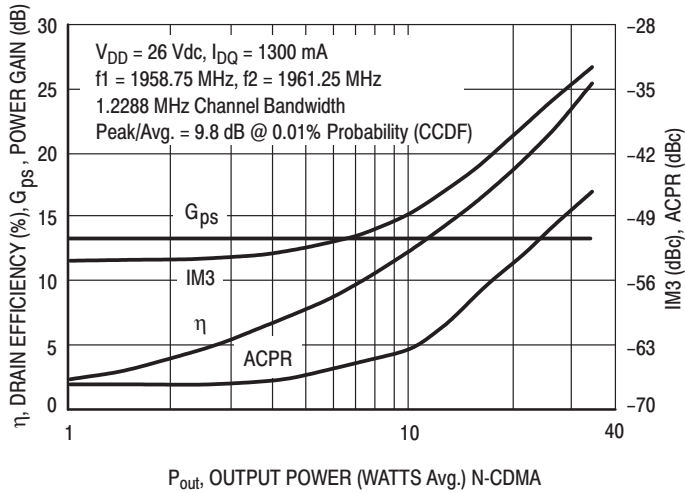
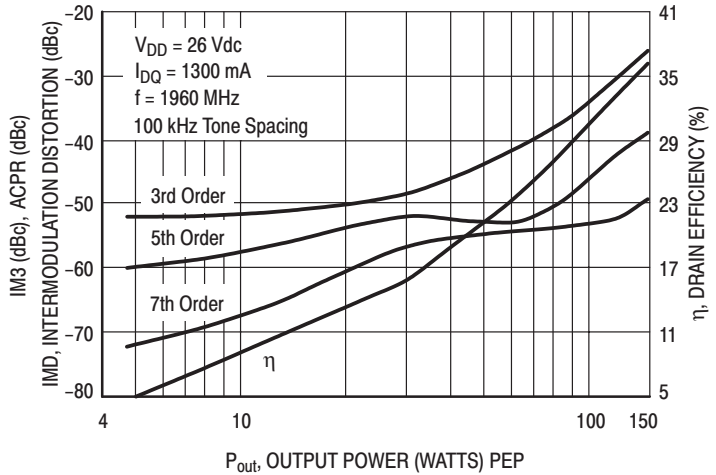


Figure 2. MRF19125 Test Circuit Component Layout

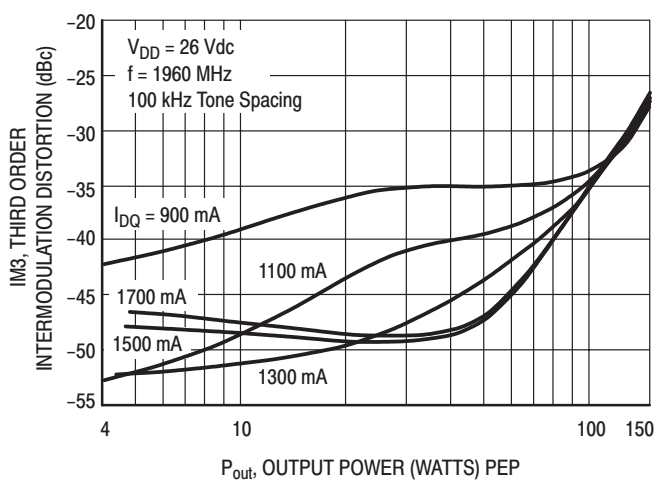
## TYPICAL CHARACTERISTICS



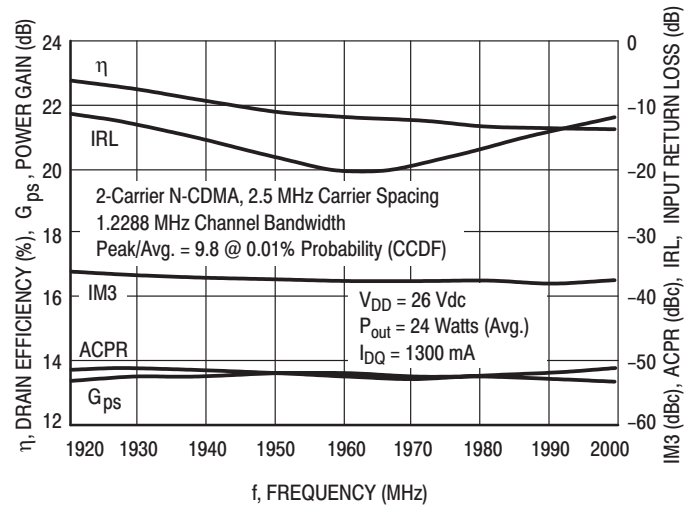
**Figure 3. 2-Carrier CDMA ACPR, IM3, Power Gain and Drain Efficiency versus Output Power**



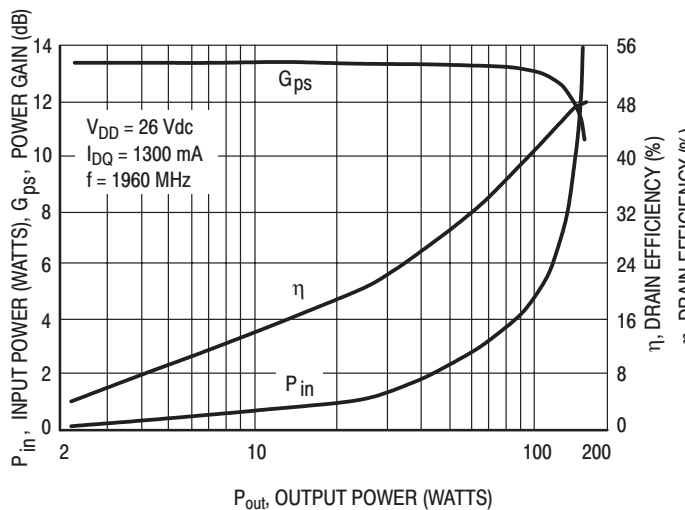
**Figure 4. Intermodulation Distortion Products versus Output Power**



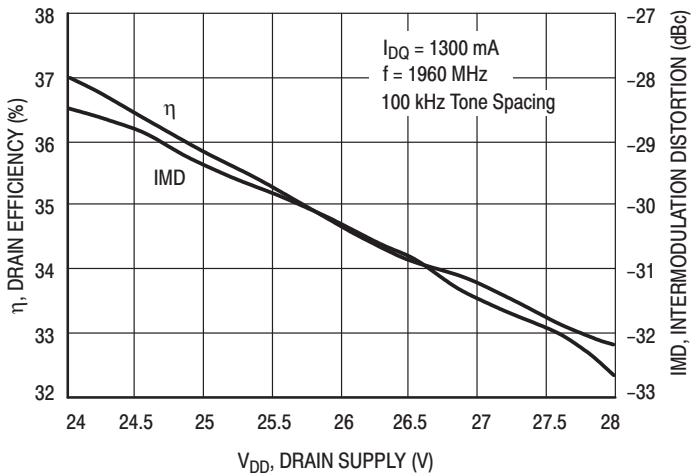
**Figure 5. Third Order Intermodulation Distortion versus Output Power**



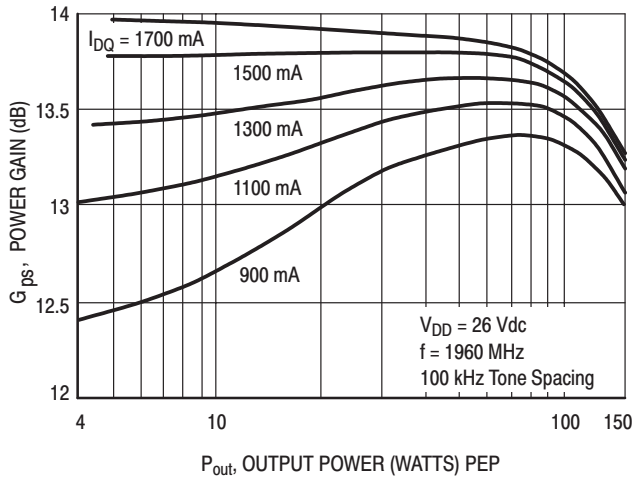
**Figure 6. 2-Carrier N-CDMA Broadband Performance**



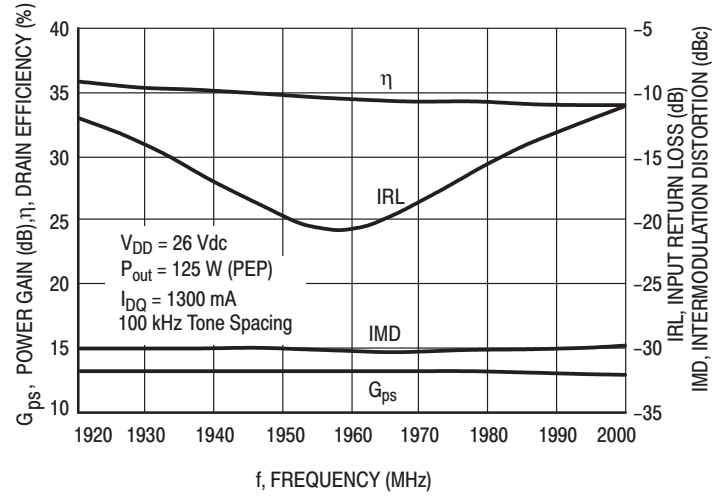
**Figure 7. CW Performance**



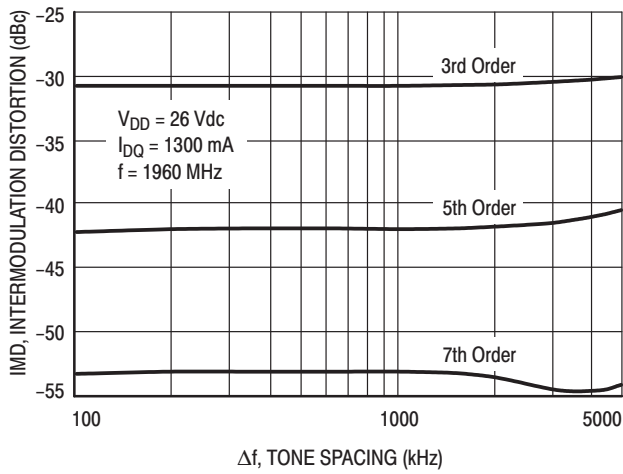
**Figure 8. Two-Tone Intermodulation Distortion and Drain Efficiency versus Drain Supply**



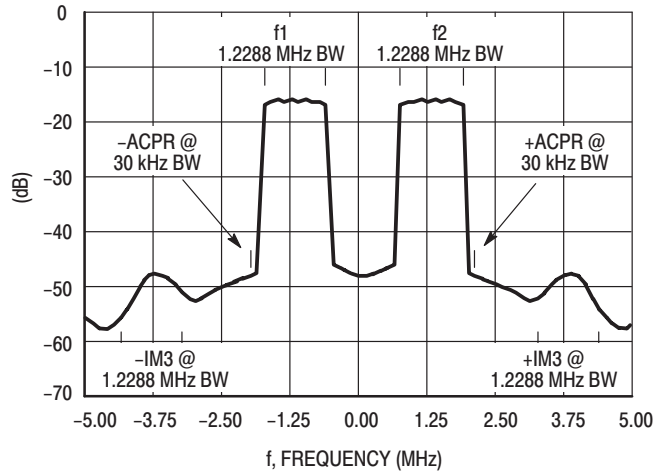
**Figure 9. Two-Tone Power Gain versus Output Power**



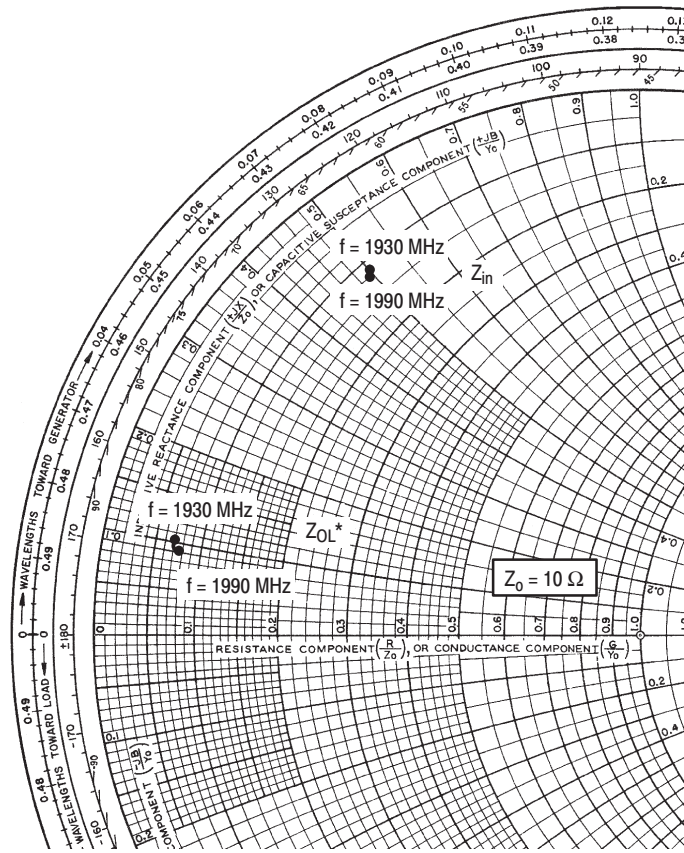
**Figure 10. Two-Tone Broadband Performance**



**Figure 11. Intermodulation Distortion Products versus Two-Tone Tone Spacing**



**Figure 12. 2-Carrier N-CDMA Spectrum**



$V_{DD} = 26 \text{ V}$ ,  $I_{DQ} = 1300 \text{ mA}$ ,  $P_{out} = 24 \text{ W (Avg.)}$

f MHz	$Z_{in}$ $\Omega$	$Z_{OL}^*$ $\Omega$
1930	$1.43 + j5.01$	$0.75 + j0.93$
1960	$1.51 + j4.88$	$0.71 + j0.89$
1990	$1.56 + j4.93$	$0.68 + j1.02$

$Z_{in}$  = Complex conjugate of source impedance.

$Z_{OL}^*$  = Complex conjugate of the optimum load impedance at a given output power, voltage, IMD, bias current and frequency.

Note:  $Z_{OL}^*$  was chosen based on tradeoffs between gain, output power, drain efficiency and intermodulation distortion.

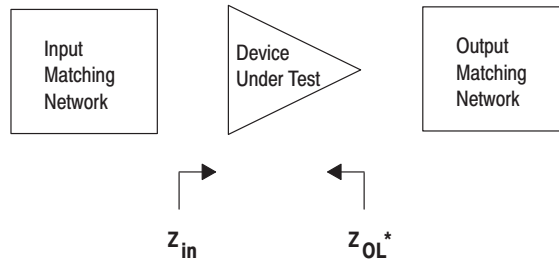


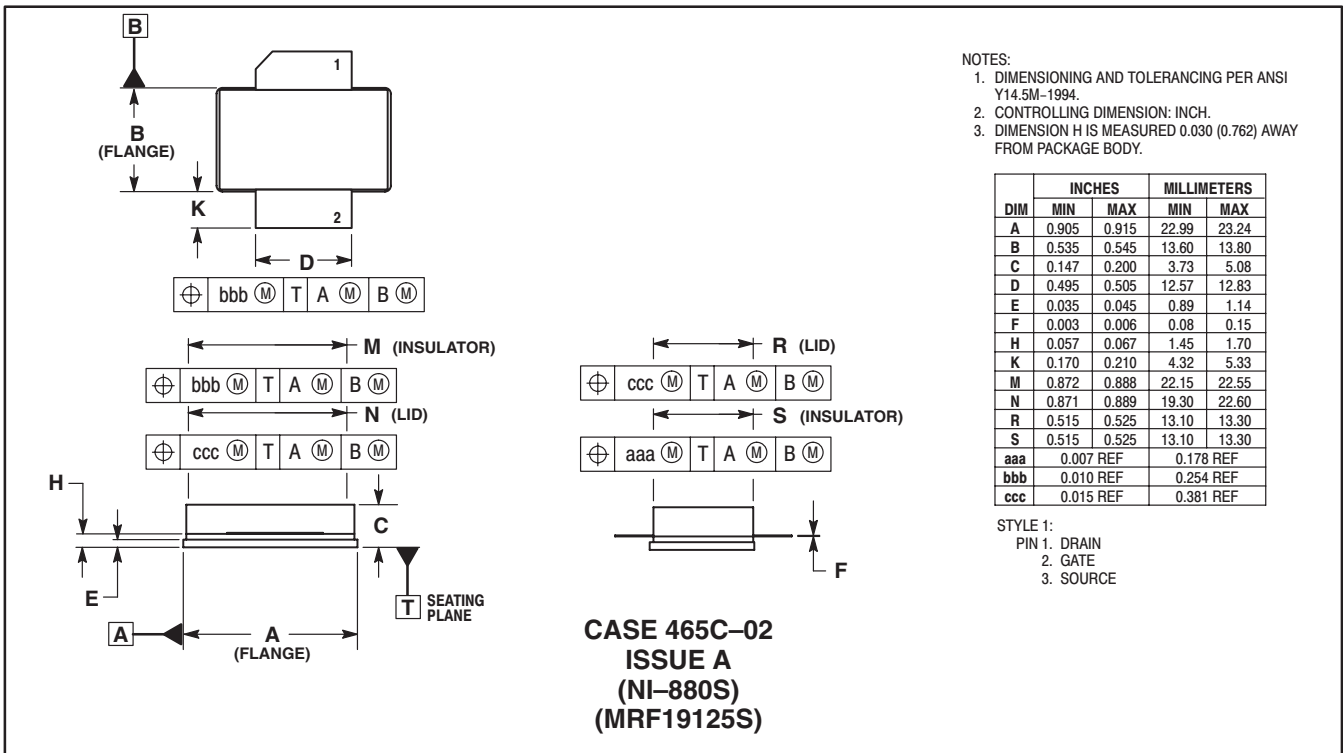
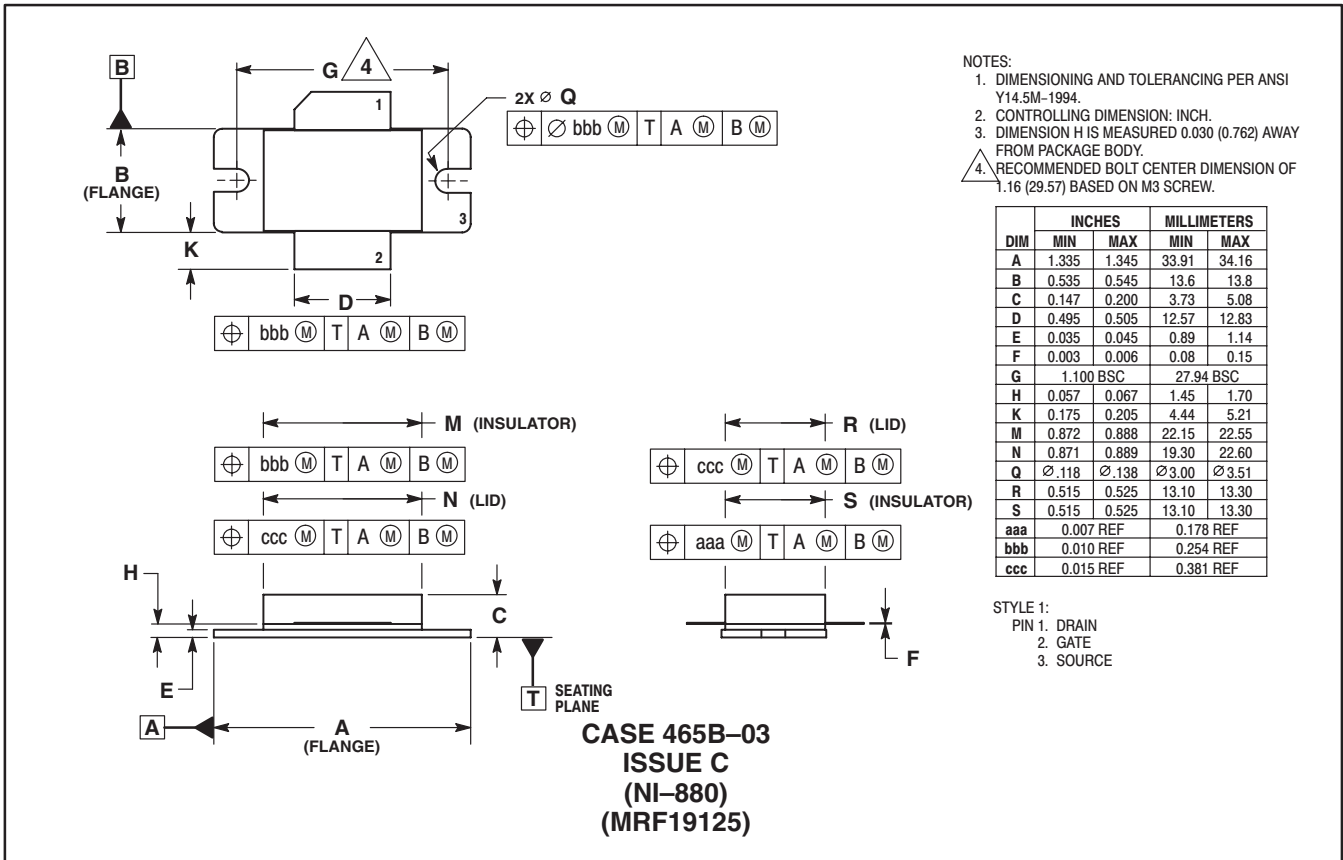
Figure 13. Series Equivalent Input and Output Impedance




# NOTES

# NOTES

## PACKAGE DIMENSIONS



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